Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/022,137	BOYD ET AL.	
Examiner	Art Unit	_
Betsey M. Hoey	1724	

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Class	class Subclass Date Examiner		
210	167		
	192		
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	205	5/9/2005	BMA
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
210	167		
	192	\rightarrow	
	194 205	5/9/2005	BMH
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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inventor name search	5/9/05 Bm)	
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